

Notice of References Cited	Application/Control No. 10/574,955		Applicant(s)/Patent Under Reexamination ADACHI ET AL.	
	Examiner SHENG HAN		Art Unit 1793	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,692,228	09-1987	Twardowski, Zbigniew	205/563
*	B	US-2006/0130610	06-2006	Ward-Close et al.	075/345
*	C	US-3,764,500	10-1973	Gibson	210/609
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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